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- 1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
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Example: optical <and> (fiber <or> fibre) <in> ti

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```
(starter<or>starting)
<paragraph>sensor<paragraph>battery<and>
(install<or>installed<or>installa
```

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Note: This function returns plural and suffixed forms of the keyword(s).

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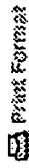
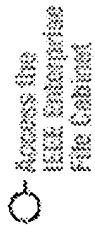
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